

**FEATURES**

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Trench Gate Soft Punch Through IGBT
- Isolated AISiC Base with AlN Substrates
- Lead Free construction

**APPLICATIONS**

- High Reliability Inverters
- Motor Controllers
- Traction Drives
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 600V to 6500V and currents up to 2400A.

The DIM670ACM65-UF000 is a 6500V, soft punch through n-channel enhancement mode, insulated gate bipolar transistor (IGBT) chopper module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

**ORDERING INFORMATION**

Order As:

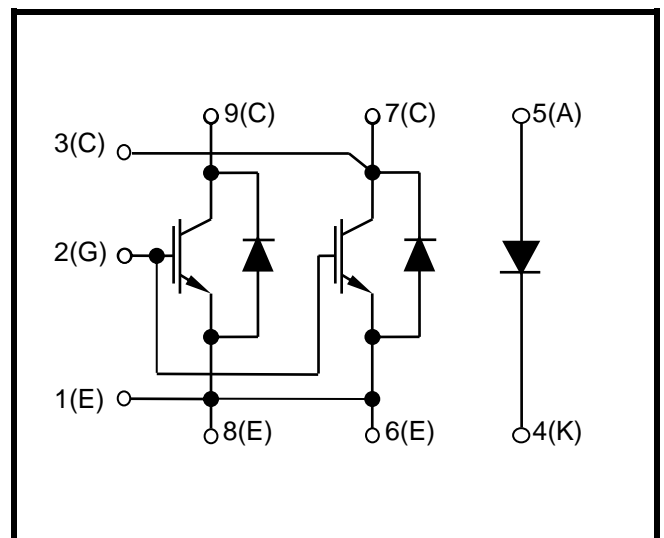
**DIM670ACM65-UF000**

Note: When ordering, please use the complete part number

**KEY PARAMETERS**

$V_{CES}$	<b>6500V</b>
$V_{CE(sat)}$ * (typ)	<b>3.6V</b>
$I_c$ (max)	<b>670A</b>
$I_{C(PK)}$ (max)	<b>1340A</b>

\* Measured at the auxiliary terminals



**Fig. 1 Circuit configuration**



**Outline type code: A**

**(See Fig. 11 for further information)**

**Fig. 2 Package**

**ABSOLUTE MAXIMUM RATINGS**

Stresses above those listed under ‘Absolute Maximum Ratings’ may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

**T<sub>case</sub> = 25°C unless stated otherwise**

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>CES</sub>	Collector-emitter voltage	V <sub>GE</sub> = 0V, T <sub>j</sub> = 150°C	6500	V
		V <sub>GE</sub> = 0V, T <sub>j</sub> = 25°C	6300	V
		V <sub>GE</sub> = 0V, T <sub>j</sub> = -50°C	5700	V
V <sub>GES</sub>	Gate-emitter voltage		±20	V
I <sub>C</sub>	Continuous collector current	T <sub>case</sub> = 112°C	670	A
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> = 148°C	1340	A
P <sub>max</sub>	Max. transistor power dissipation	T <sub>case</sub> = 25°C, T <sub>j</sub> = 150°C	8.9	kW
I <sup>2</sup> t	Diode I <sup>2</sup> t value (IGBT arm)	V <sub>R</sub> = 0, t <sub>p</sub> = 10ms, T <sub>j</sub> = 150°C	208	kA <sup>2</sup> s
	Diode I <sup>2</sup> t value (Diode arm)		208	kA <sup>2</sup> s
V <sub>isol</sub>	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	10.2	kV
Q <sub>PD</sub>	Partial discharge – per module	IEC1287, V <sub>1</sub> = 6900V, V <sub>2</sub> = 5100V, 50Hz RMS	10	pC

**THERMAL AND MECHANICAL RATINGS**

Internal insulation material:	AlN
Baseplate material:	AlSiC
Creepage distance:	56mm
Clearance:	26mm
CTI (Comparative Tracking Index):	>600

Symbol	Parameter	Test Conditions	Min	Typ.	Max	Units
R <sub>th(j-c)</sub>	Thermal resistance – transistor	Continuous dissipation – junction to case			14	°C/kW
R <sub>th(j-c)</sub>	Thermal resistance – diode (IGBT arm)	Continuous dissipation – junction to case			27	°C/kW
R <sub>th(j-c)</sub>	Thermal resistance – diode (Diode arm)	Continuous dissipation – junction to case			27	°C/kW
R <sub>th(c-h)</sub>	Thermal resistance – case to heatsink	Mounting torque 5Nm (with mounting grease)			8	°C/kW
T <sub>j</sub>	Junction temperature	Transistor			150	°C
		Diode			150	°C
T <sub>stg</sub>	Storage temperature range		-40		125	°C
	Screw torque	Mounting – M6			5	Nm
		Electrical connections – M4			2	Nm
		Electrical connections – M8			10	Nm

**ELECTRICAL CHARACTERISTICS**

**T<sub>case</sub> = 25°C unless stated otherwise.**

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
I <sub>CES</sub>	Collector cut-off current	V <sub>GE</sub> = 0V, V <sub>CE</sub> = V <sub>CES</sub>			4	mA
		V <sub>GE</sub> = 0V, V <sub>CE</sub> = V <sub>CES</sub> , T <sub>case</sub> = 150°C			135	mA
I <sub>GES</sub>	Gate leakage current	V <sub>GE</sub> = ± 20V, V <sub>CE</sub> = 0V			1	µA
V <sub>GE(TH)</sub>	Gate threshold voltage	I <sub>C</sub> = 120mA, V <sub>GE</sub> = V <sub>CE</sub>	6.5	6.75	7.3	V
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 670A		3.6		V
		V <sub>GE</sub> = 15V, I <sub>C</sub> = 670A, T <sub>j</sub> = 125°C		4.0		V
		V <sub>GE</sub> = 15V, I <sub>C</sub> = 670A, T <sub>j</sub> = 150°C		4.1		V
I <sub>F</sub>	Diode forward current	DC			670	A
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms			1340	A
V <sub>F</sub>	Diode forward voltage	I <sub>F</sub> = 670A		3.8		V
		I <sub>F</sub> = 670A, T <sub>j</sub> = 125°C		4.15		V
		I <sub>F</sub> = 670A, T <sub>j</sub> = 150°C		4.2		V
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 100kHz		117		nF
Q <sub>g</sub>	Gate charge	±15V		10		µC
C <sub>res</sub>	Reverse transfer capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 100kHz		4		nF
L <sub>M</sub>	Module inductance	IGBT		15		nH
		Diode		15		nH
R <sub>INT</sub>	Internal resistance	IGBT		135		µΩ
		Diode		270		µΩ
SC <sub>Data</sub>	Short circuit current, I <sub>SC</sub>	T <sub>j</sub> = 125°C, V <sub>CC</sub> = 4400V t <sub>p</sub> ≤ 10µs, V <sub>GE</sub> ≤ 15V V <sub>CE(max)</sub> = V <sub>CES</sub> - L* x di/dt IEC 60747-9		3000		A

**Note:**

\* L is the circuit inductance + L<sub>M</sub>

**ELECTRICAL CHARACTERISTICS**

**T<sub>case</sub> = 25°C unless stated otherwise**

Symbol	Parameter	Test Conditions	Min	Typ.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 670A V <sub>GE</sub> = ±15V V <sub>CE</sub> = 3600V R <sub>G(ON)</sub> = 2.2Ω R <sub>G(OFF)</sub> = 22Ω C <sub>ge</sub> = 100nF L <sub>S</sub> ~ 280nH		4.5		μs
t <sub>f</sub>	Fall time			400		ns
E <sub>OFF</sub>	Turn-off energy loss			3200		mJ
t <sub>d(on)</sub>	Turn-on delay time			720		ns
t <sub>r</sub>	Rise time			290		ns
E <sub>ON</sub>	Turn-on energy loss			5000		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 670A V <sub>CE</sub> = 3600V di <sub>F</sub> /dt = 2700A/μs		1100		μC
I <sub>rr</sub>	Diode reverse recovery current			1300		A
E <sub>rec</sub>	Diode reverse recovery energy			1800		mJ

**T<sub>case</sub> = 125°C unless stated otherwise**

Symbol	Parameter	Test Conditions	Min	Typ.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 670A V <sub>GE</sub> = ±15V V <sub>CE</sub> = 3600V R <sub>G(ON)</sub> = 2.2Ω R <sub>G(OFF)</sub> = 22Ω C <sub>ge</sub> = 100nF L <sub>S</sub> ~ 280nH		5		μs
t <sub>f</sub>	Fall time			500		ns
E <sub>OFF</sub>	Turn-off energy loss			3700		mJ
t <sub>d(on)</sub>	Turn-on delay time			740		ns
t <sub>r</sub>	Rise time			250		ns
E <sub>ON</sub>	Turn-on energy loss			6400		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 670A V <sub>CE</sub> = 3600V di <sub>F</sub> /dt = 2700A/μs		1910		μC
I <sub>rr</sub>	Diode reverse recovery current			1570		A
E <sub>rec</sub>	Diode reverse recovery energy			3200		mJ

**T<sub>case</sub> = 150°C unless stated otherwise**

Symbol	Parameter	Test Conditions	Min	Typ.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 670A V <sub>GE</sub> = ±15V V <sub>CE</sub> = 3600V R <sub>G(ON)</sub> = 2.2Ω R <sub>G(OFF)</sub> = 22Ω C <sub>ge</sub> = 100nF L <sub>S</sub> ~ 280nH		5		μs
t <sub>f</sub>	Fall time			520		ns
E <sub>OFF</sub>	Turn-off energy loss			3800		mJ
t <sub>d(on)</sub>	Turn-on delay time			750		ns
t <sub>r</sub>	Rise time			230		ns
E <sub>ON</sub>	Turn-on energy loss			6700		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 670A V <sub>CE</sub> = 3600V di <sub>F</sub> /dt = 2700A/μs		1910		μC
I <sub>rr</sub>	Diode reverse recovery current			1570		A
E <sub>rec</sub>	Diode reverse recovery energy			3400		mJ

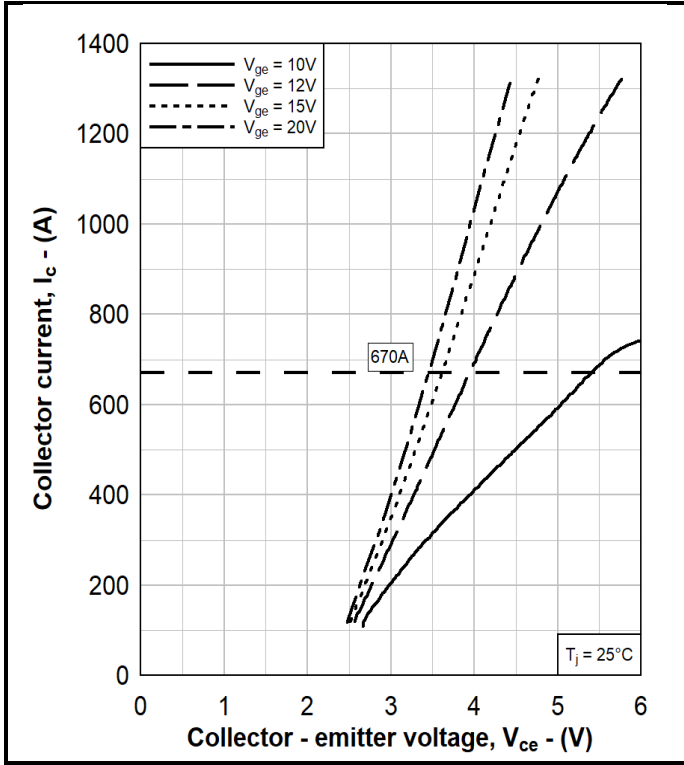


Fig. 3 Typical output characteristics

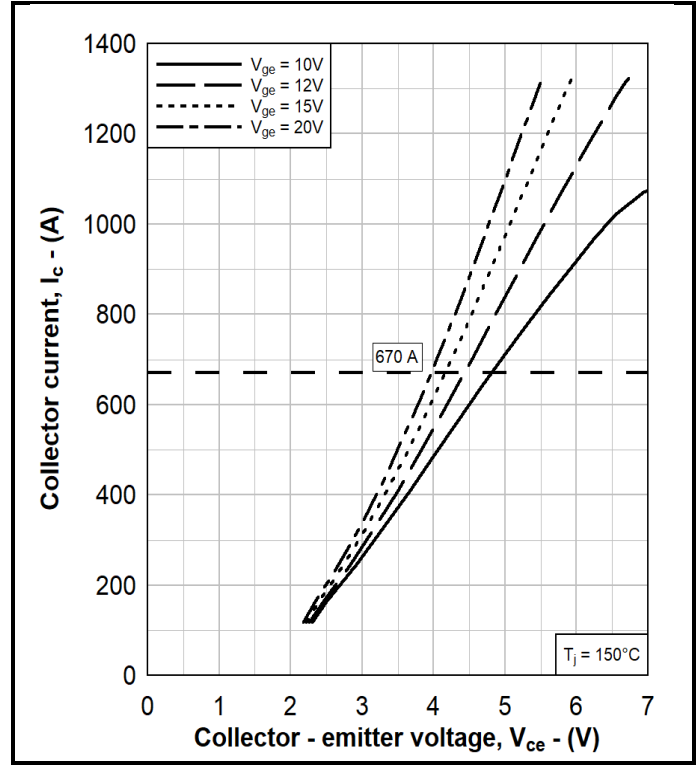


Fig. 4 Typical output characteristics

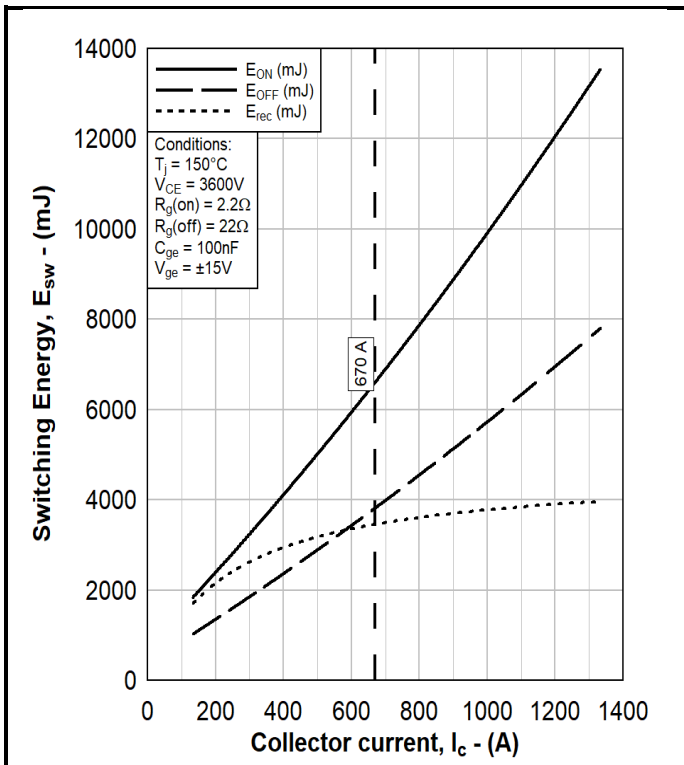


Fig. 5 Typical switching energy vs collector current

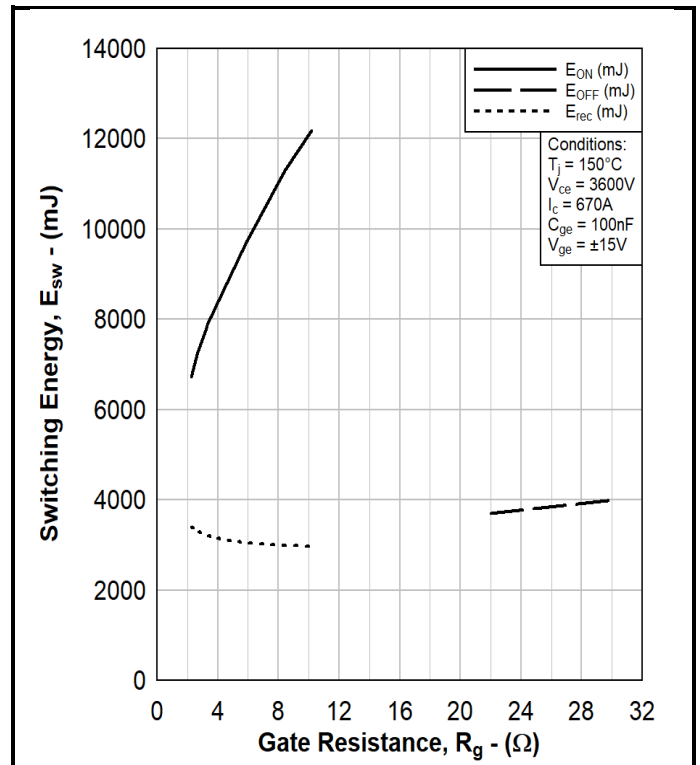


Fig. 6 Typical switching energy vs gate resistance

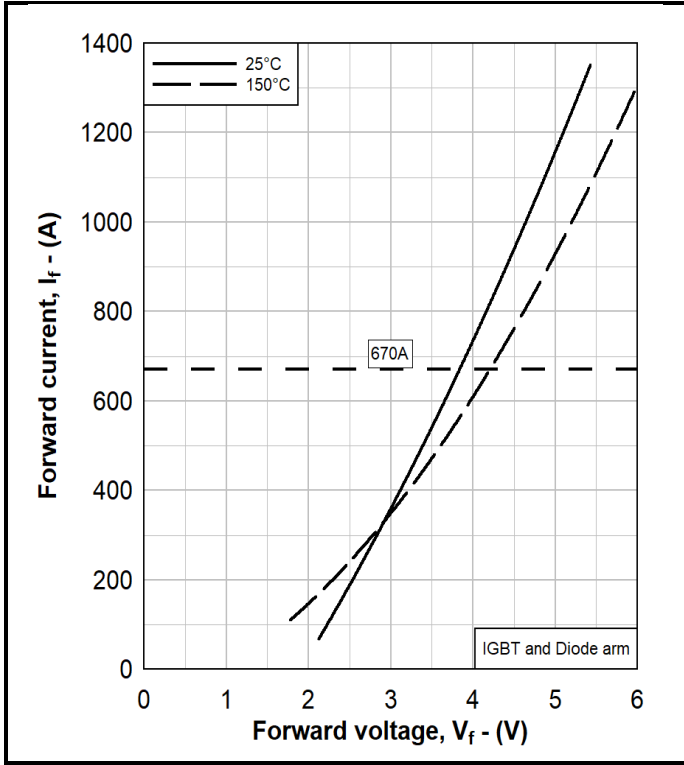


Fig. 7 Diode typical forward characteristics

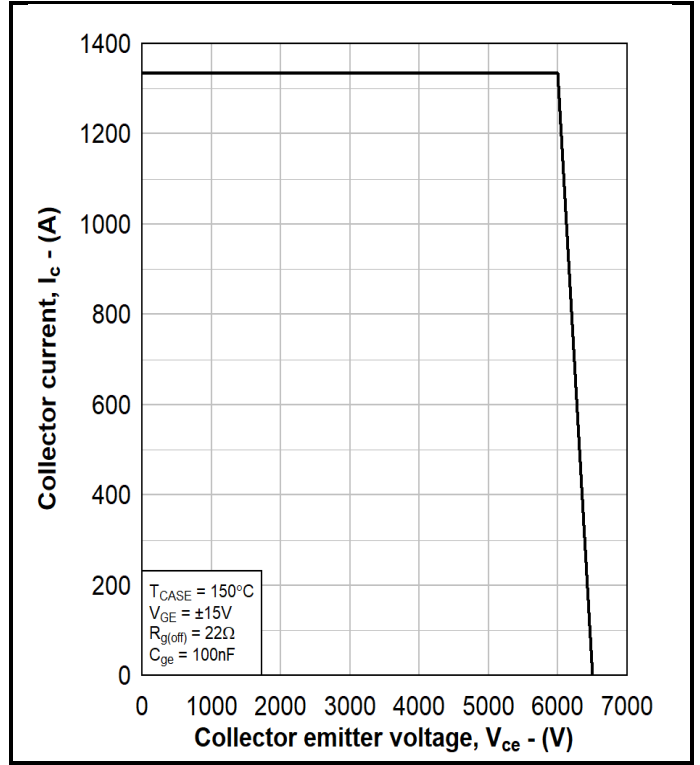


Fig. 8 Reverse bias safe operating area

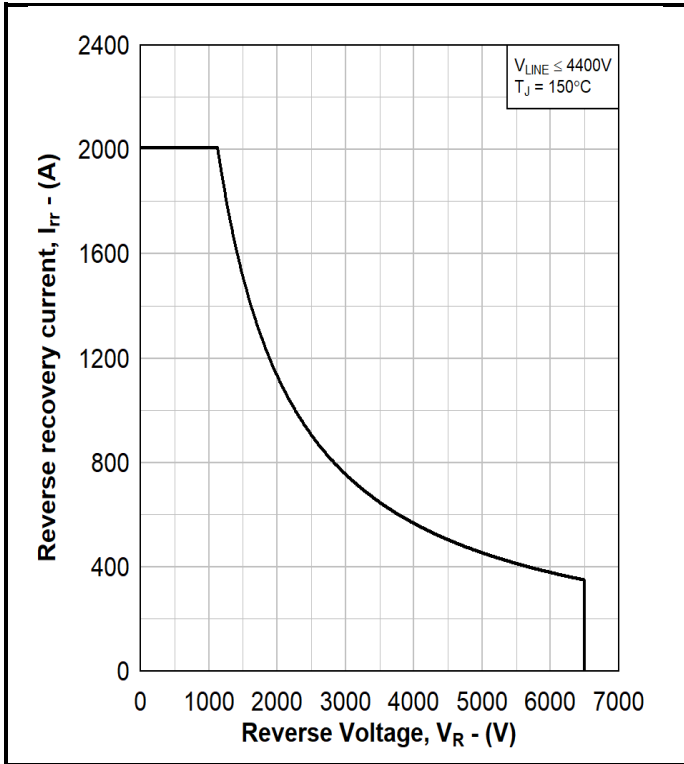


Fig. 9 Diode reverse bias safe operating area

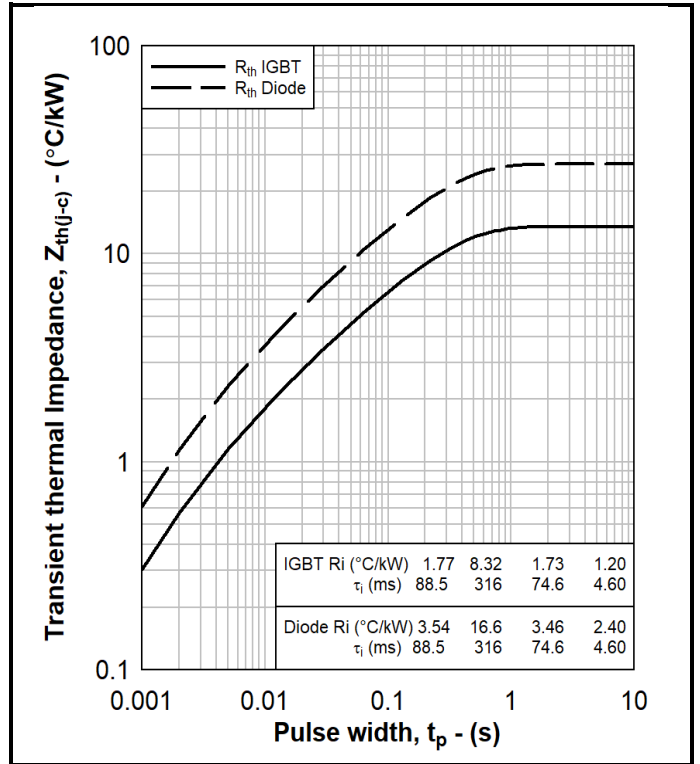
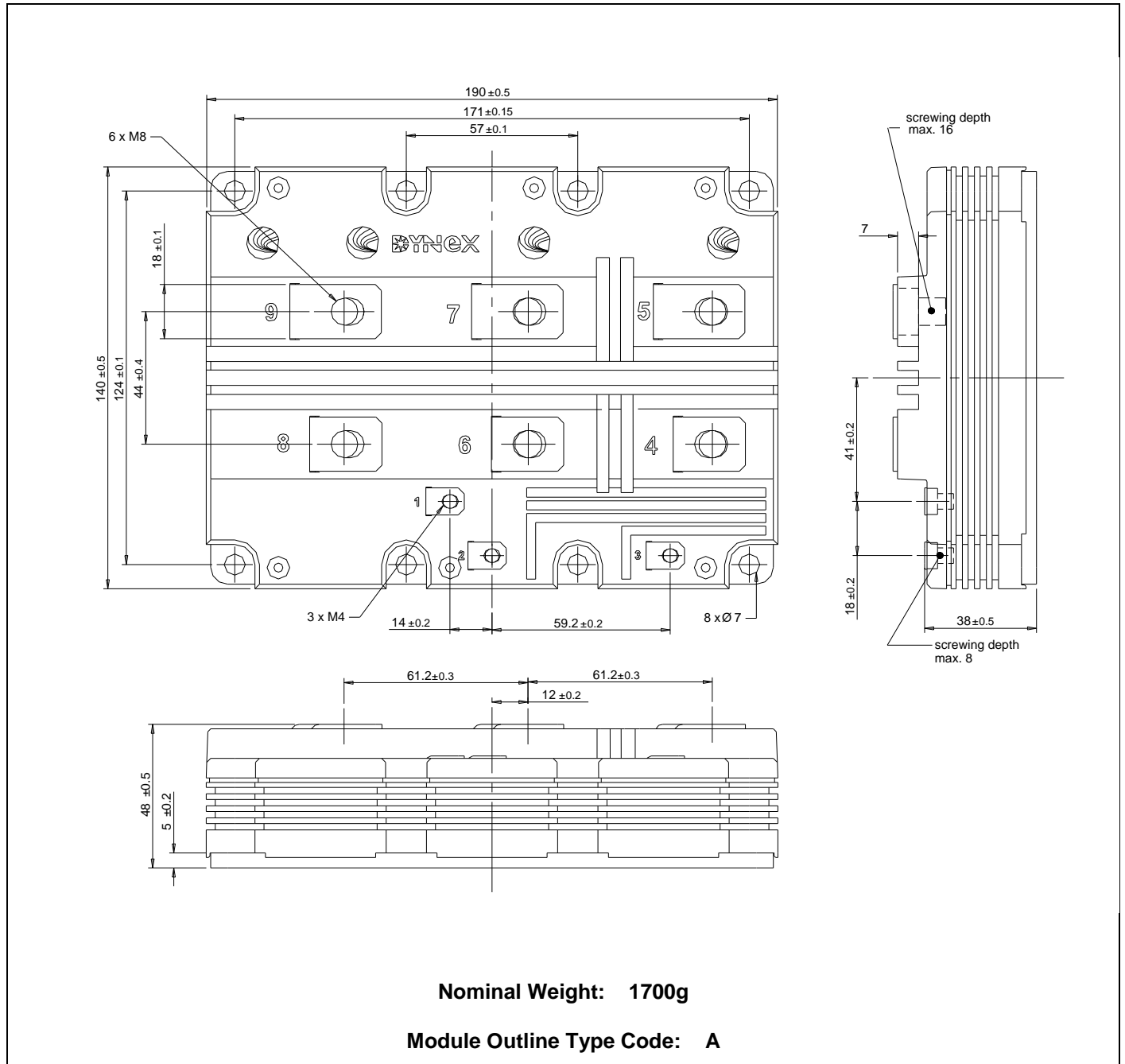


Fig. 10 Transient thermal impedance

**PACKAGE DETAILS**

For further package information, please visit our website or contact Customer Services.  
 All dimensions in mm, unless stated otherwise.  
**DO NOT SCALE.**



**Nominal Weight: 1700g**

**Module Outline Type Code: A**

**Fig. 11 Module outline drawing**

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